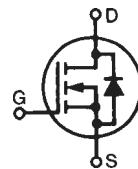


TrenchMV™ Power MOSFET

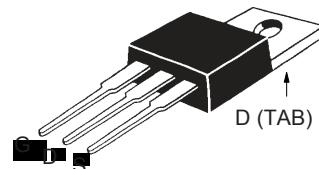
IXTP44N10T IXTY44N10T

V_{DSS} = 100 V
 I_{D25} = 44 A
 $R_{DS(on)}$ ≤ 30 mΩ

N-Channel Enhancement Mode
Avalanche Rated

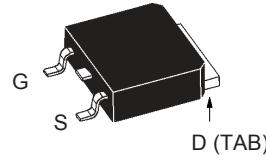


TO-220 (IXTP)



Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ C$ to $175^\circ C$	100	V	
V_{DGR}	$T_J = 25^\circ C$ to $175^\circ C$; $R_{GS} = 1 M\Omega$	100	V	
V_{GSM}	Transient	± 30	V	
I_{D25}	$T_c = 25^\circ C$	44	A	
I_L	Package Current Limit, RMS	25	A	TO-252A
I_{DM}	$T_c = 25^\circ C$, pulse width limited by T_{JM}	140	A	
I_{AR}	$T_c = 25^\circ C$	10	A	
E_{AS}	$T_c = 25^\circ C$	250	mJ	
dv/dt	$I_S \leq I_{DM}$, $di/dt \leq 100 A/\mu s$, $V_{DD} \leq V_{DSS}$ $T_J \leq 175^\circ C$, $R_G = 18 \Omega$	3	V/ns	
P_D	$T_c = 25^\circ C$	130	W	
T_J		-55 ... +175	°C	
T_{JM}		175	°C	
T_{stg}		-40 ... +175	°C	
T_L	1.6 mm (0.062 in.) from case for 10 s	300	°C	
T_{SOLD}	Plastic body for 10 seconds	260	°C	
M_d	Mounting torque (TO-220)	1.13 / 10	Nm/lb.in.	
Weight	TO-220 TO-252	3 0.8	g g	

TO-252 AA (IXTY)



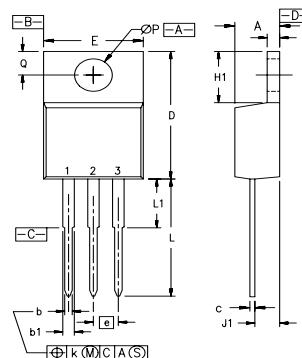
G = Gate D = Drain
 S = Source TAB = Drain

Symbol	Test Conditions ($T_J = 25^\circ C$ unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
BV_{DSS}	$V_{GS} = 0 V$, $I_D = 250 \mu A$	85		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 25 \mu A$	2.5		4.5 V
I_{GSS}	$V_{GS} = \pm 20 V$, $V_{DS} = 0 V$		± 100	nA
I_{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 V$		1 100	μA μA
$R_{DS(on)}$	$V_{GS} = 10 V$, $I_D = 22 A$, Notes 1, 2	22	30	mΩ

Symbol	Test Conditions	Characteristic Values		
	($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
g_{fs}	$V_{DS} = 10 \text{ V}; I_D = 0.5 I_{D25}$, Note 1	13	21	S
C_{iss}		1262		pF
C_{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	190		pF
C_{rss}		43		pF
$t_{d(on)}$	Resistive Switching Times			21 ns
t_r	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 10 \text{ A}$	47		ns
$t_{d(off)}$	$R_G = 18 \Omega$ (External)	36		ns
t_f		32		ns
$Q_{g(on)}$		33		nC
Q_{gs}	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 10 \text{ A}$	10		nC
Q_{gd}		11		nC
R_{thJC}			1.15	°C/W
R_{thCS}	TO-220	0.5		°C/W

Source-Drain Diode

Symbol	Test Conditions	Characteristic Values		
	($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
I_s	$V_{GS} = 0 \text{ V}$		44	A
I_{SM}	Repetitive		140	A
V_{SD}	$I_F = 25 \text{ A}, V_{GS} = 0 \text{ V}$, Note 1		1.1	V
t_{rr}	$I_F = 25 \text{ A}, -di/dt = 100 \text{ A}/\mu\text{s}$ $V_R = 50 \text{ V}, V_{GS} = 0 \text{ V}$	100		ns

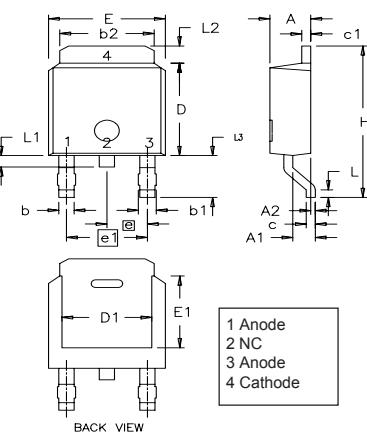
TO-220 (IXTP) Outline

Pins: 1 - Gate 2 - Drain
3 - Source 4, TAB - Drain

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.170	.190	4.32	4.83
b	.025	.040	0.64	1.02
b1	.045	.065	1.15	1.65
c	.014	.022	0.35	0.56
D	.580	.630	14.73	16.00
E	.390	.420	9.91	10.66
e	.100 BSC		2.54 BSC	
F	.045	.055	1.14	1.40
H1	.230	.270	5.85	6.85
J1	.090	.110	2.29	2.79
k	0	.015	0	0.38
L	.500	.550	12.70	13.97
L1	.110	.230	2.79	5.84
L2				
$\emptyset P$.139	.161	3.53	4.08
Q	.100	.125	2.54	3.18

Notes:

1. Pulse test: $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2\%$;
2. On through-hole packages, $R_{DS(on)}$ Kelvin test contact location must be 5 mm or less from the package body.

TO-252 (IXTY) Outline

Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	2.19	2.38	0.086	0.094
A1	0.89	1.14	0.035	0.045
A2	0	0.13	0	0.005
b	0.64	0.89	0.025	0.035
b1	0.76	1.14	0.030	0.045
b2	5.21	5.46	0.205	0.215
c	0.46	0.58	0.018	0.023
c1	0.46	0.58	0.018	0.023
D	5.97	6.22	0.235	0.245
D1	4.32	5.21	0.170	0.205
E	6.35	6.73	0.250	0.265
E1	4.32	5.21	0.170	0.205
e	2.28 BSC		0.090 BSC	
e1	4.57 BSC		0.180 BSC	
H	9.40	10.42	0.370	0.410
L	0.51	1.02	0.020	0.040
L1	0.64	1.02	0.025	0.040
L2	0.89	1.27	0.035	0.050
L3	2.54	2.92	0.100	0.115

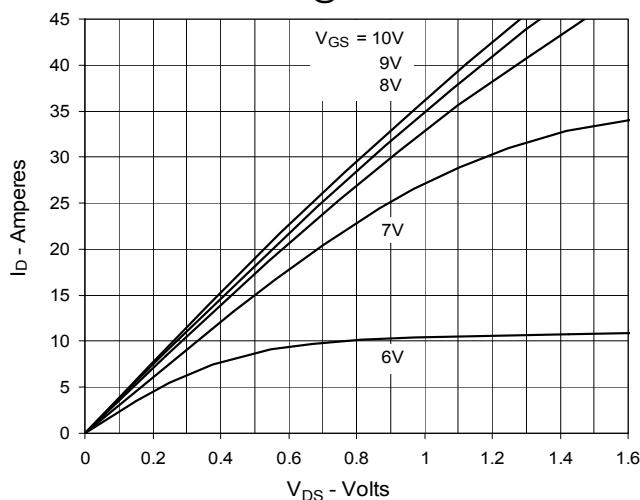
PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

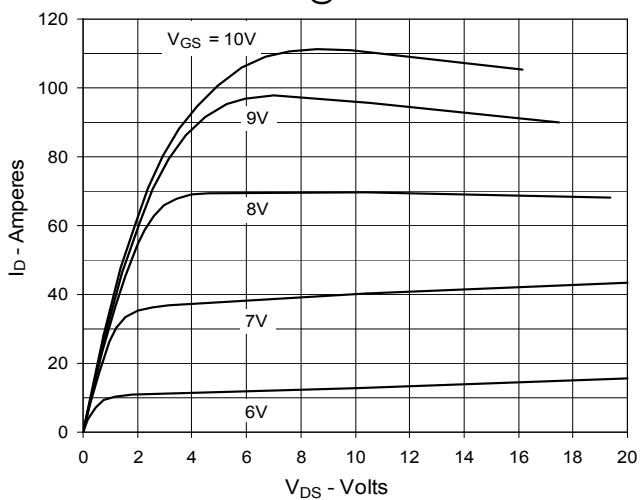
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

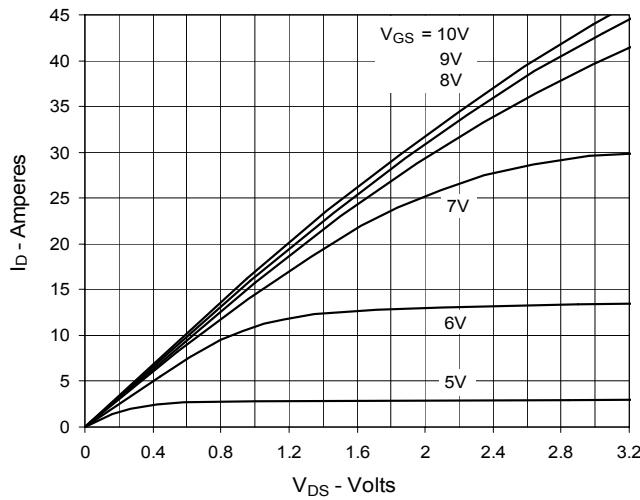
**Fig. 1. Output Characteristics
@ 25°C**



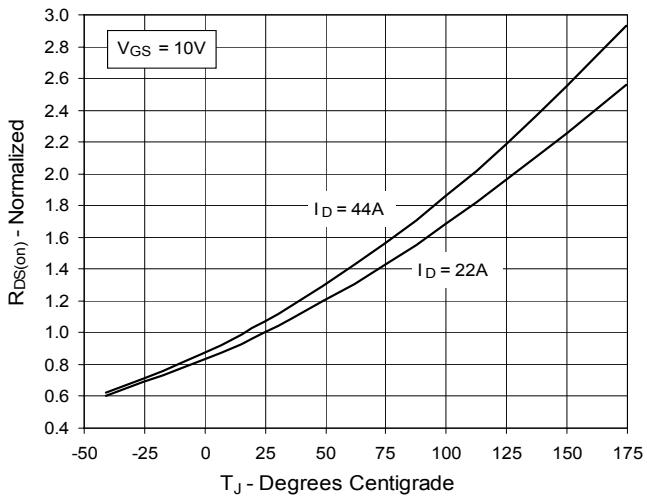
**Fig. 2. Extended Output Characteristics
@ 25°C**



**Fig. 3. Output Characteristics
@ 150°C**



**Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 22A$ Value
vs. Junction Temperature**



**Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 22A$ Value
vs. Drain Current**

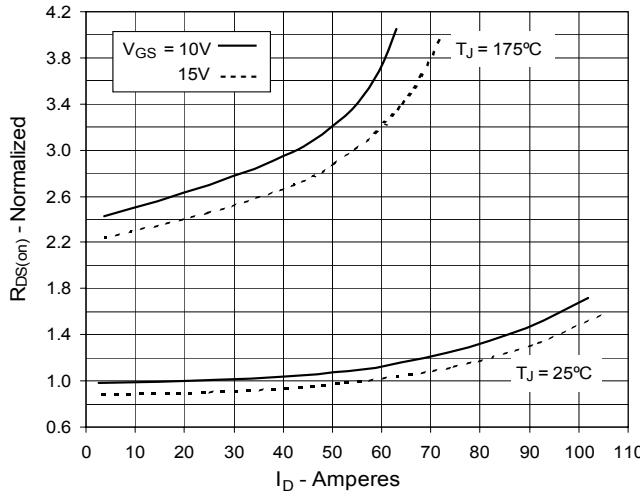


Fig. 6. Drain Current vs. Case Temperature

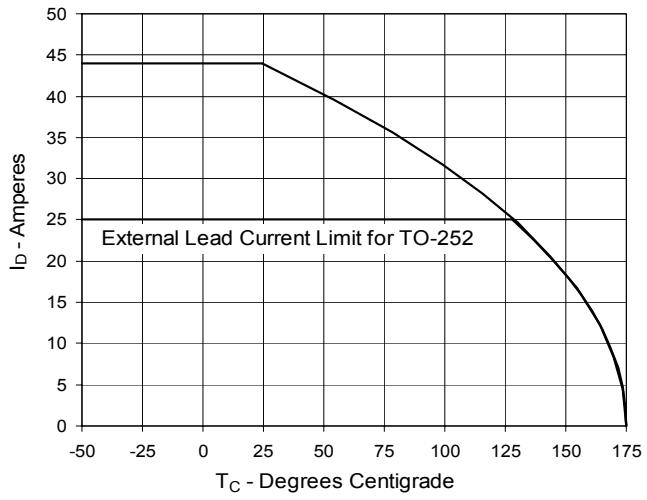
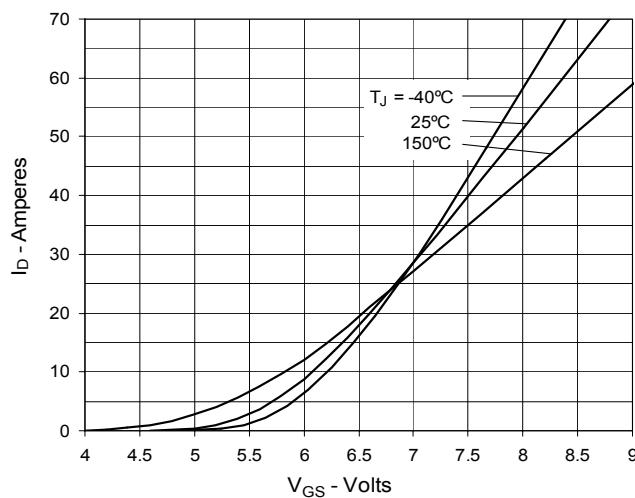
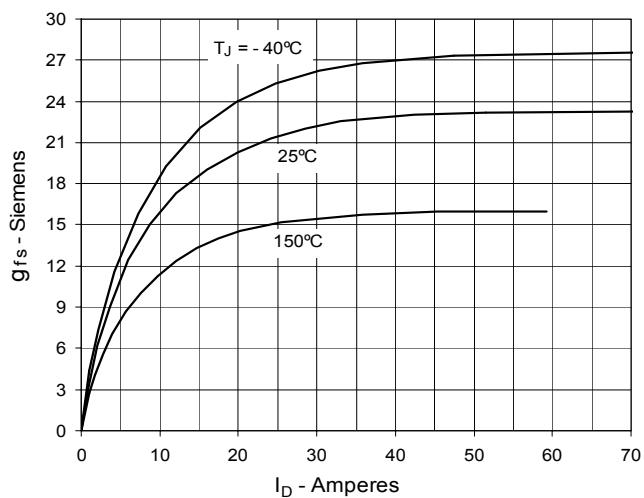
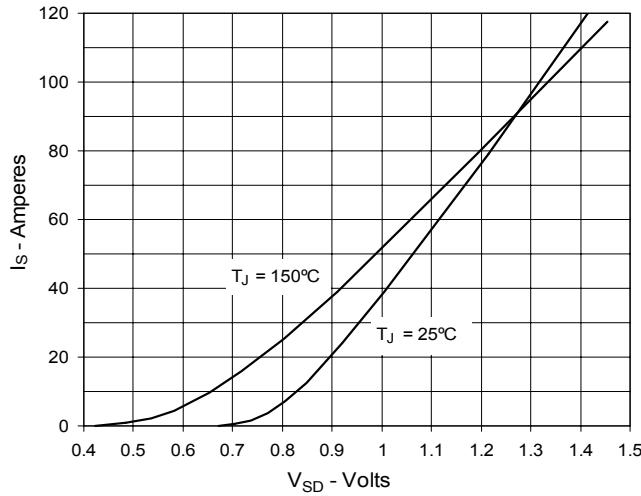
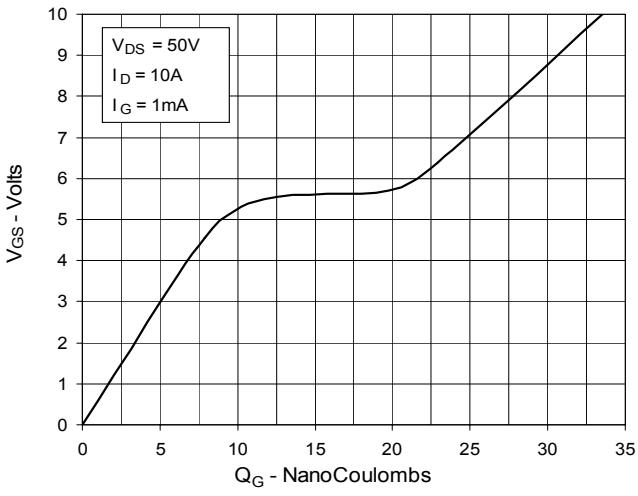
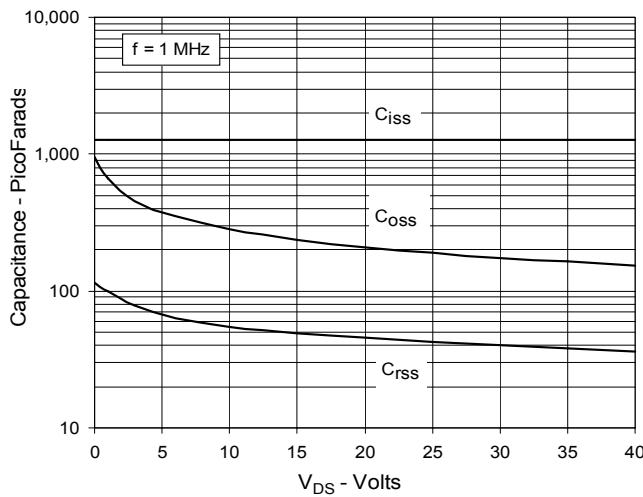
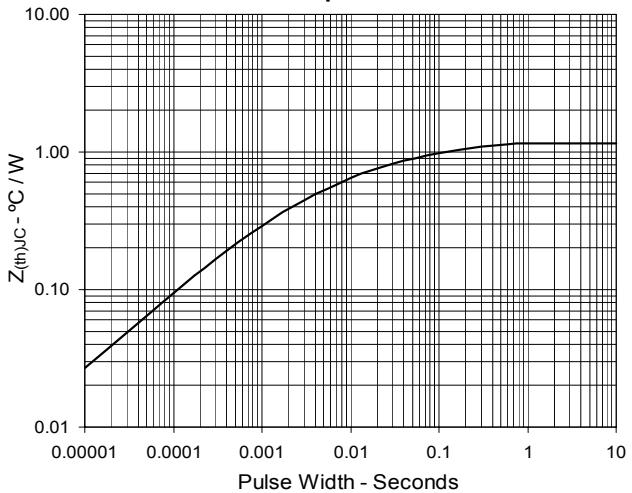
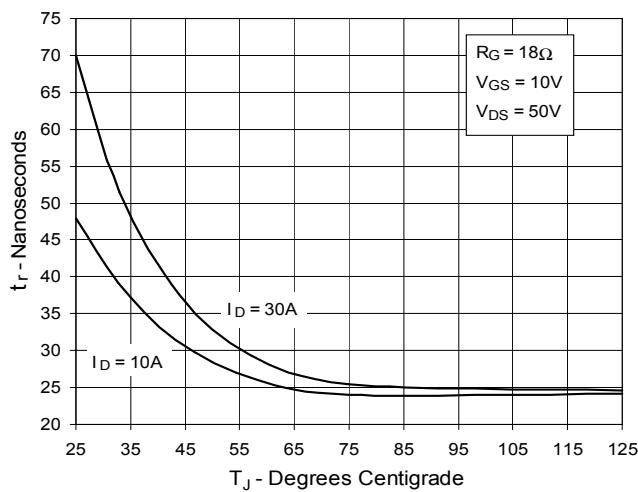
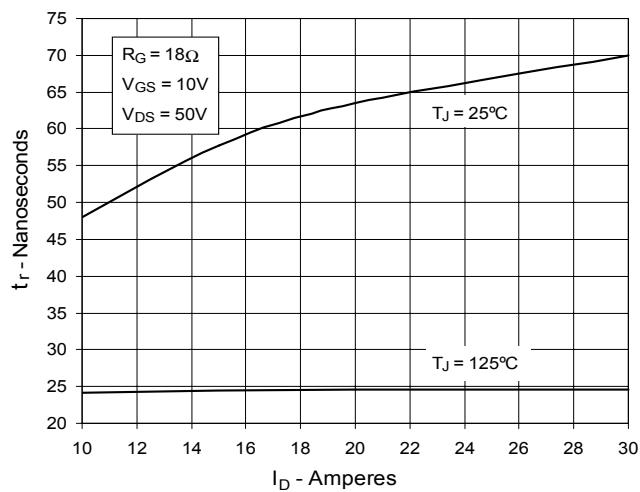


Fig. 7. Input Admittance**Fig. 8. Transconductance****Fig. 9. Forward Voltage Drop of Intrinsic Diode****Fig. 10. Gate Charge****Fig. 11. Capacitance****Fig. 12. Maximum Transient Thermal Impedance**

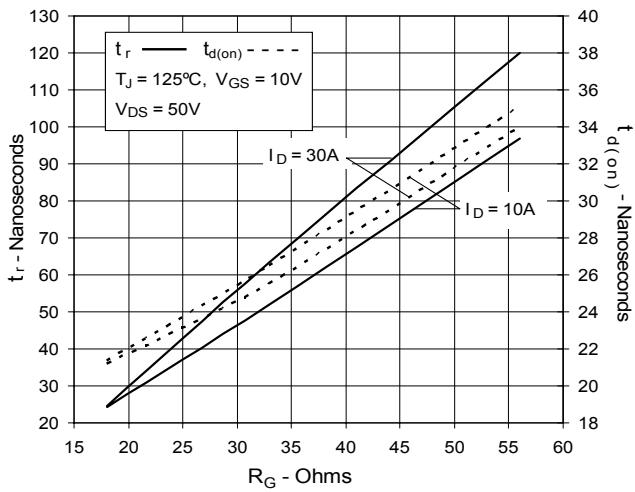
**Fig. 13. Resistive Turn-on
Rise Time vs. Junction Temperature**



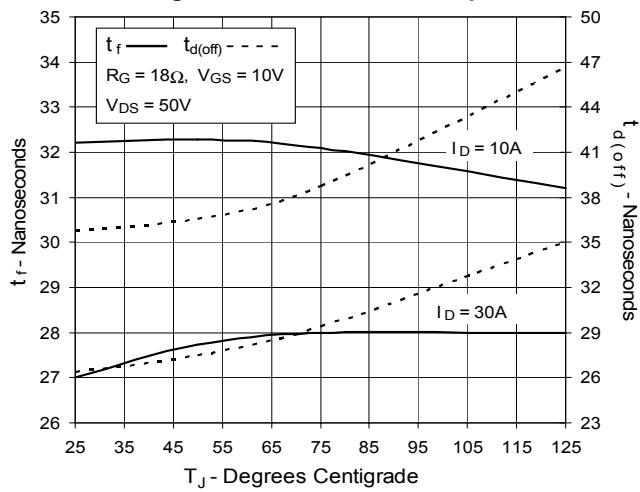
**Fig. 14. Resistive Turn-on
Rise Time vs. Drain Current**



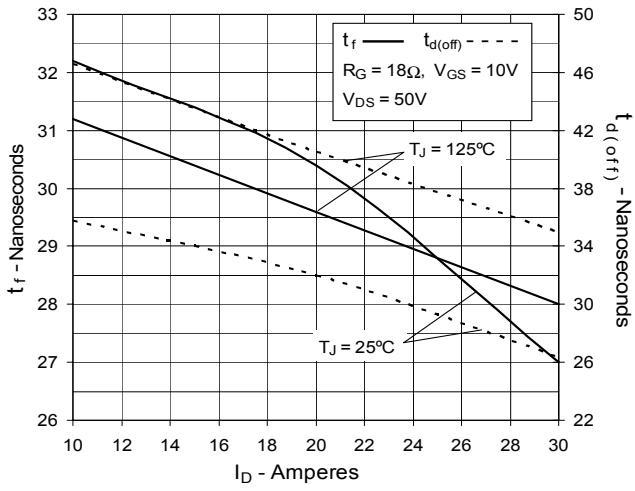
**Fig. 15. Resistive Turn-on
Switching Times vs. Gate Resistance**



**Fig. 16. Resistive Turn-off
Switching Times vs. Junction Temperature**



**Fig. 17. Resistive Turn-off
Switching Times vs. Drain Current**



**Fig. 18. Resistive Turn-off
Switching Times vs. Gate Resistance**

